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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/675,344	RUSH ET AL.	
Examiner	Art Unit	
EDMUND H. LEE	1732	

SEARCHED				
Class	Subclass	Date	Examiner	
UPDATED		7/21/2005	EHL	
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
320	7/21/2005	EHL			
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	Subclass	Subclass Date 320 7/21/2005			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	7/21/2005	EHL		
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